## Search Notes



Appl	ication/	Contro	l No
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Examiner

Shin, Kyung H

Applicant(s)/Patent Under Reexamination

NIWA ET AL.

Art Unit

2143

## **SEARCHED**

Class	Subclass	Date	Examiner
709	238, 249, 230	8/17/07	KHS
710	305, 306	8/17/07	KHS
370	392, 463, 466	8/17/07	KHS

## **SEARCH NOTES**

Search Notes	Date	Examiner
Search Rpt. included	8/17/07	KHS
IEEE, NPL, Google search	8/17/07	KHS
Consulted with PWU, JEFFREY C (SPE)	. 8/16/07	KHS

## **INTERFERENCE SEARCH**

Class	Subclass	. Date	Examiner
710	305, 306	8/17/07	KHS
370	392. 463, 466	8/17/07	KHS

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